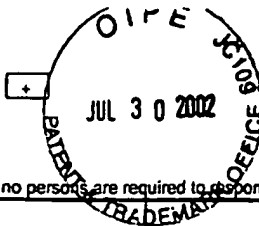


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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)		Application Number	10/086.137
		Filing Date	February 26, 2002
		First Named Inventor	Zhang, et al.
		Group Art Unit	2881
		Examiner Name	N/A
Sheet 1 of 1	Attorney Docket Number	NUFO-011	

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U.S. PATENT DOCUMENTS						
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	U.S. Patent Documents		Name of Patentee or Applicant of Cited Documents	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code <sup>2</sup> (if known)			
TN		6,404,798		Leckel et al.	06/11/02	

FOREIGN PATENT DOCUMENTS								
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OTHER PRIOR ART—NON PATENT LITERATURE DOCUMENTS			
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TN		Carl E. Wieman "Using Diode Lasers for Atomic Physics" Review Article, Rev. Sci. Instrum 62(1), January 1991; pp 1-20	
TN		Leckel, et al., "Impact of Source Spontaneous Emission (SSE) on the Measurement of DWDM Components" Trends in Optics and Photonics, Tops Vol. 37, March 7-10, 2002, pp 31-33	
TN		Fulop et al., "High Power A-S-E-free Tunable Laser Using a Sagnac Ring Interferometer within the External Cavity" Optical Fiber Communication Conference and Exhibit, March 17-22, 2001 Technical Digest, TuJ6-1-3	

Examiner Signature		Date Considered	7/17/03
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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